Reexamination 10/521,943 SUEHIRO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1

David J. Makiya

Application/Control No.

				U.S. PATENT DOCUM	MENTS	
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY		Name	Classification
*	Α	US-7,281,823 B2	10-2007	Moisel, Joerg		362/294
	В	US-				
	С	US-				
	D	US-				
	Е	US-				
	F	US-				
	G	US-				
	Н	US-				
	Т	US-				
	J	US-				
	к	US-				
	L	US-				
	М	US-				
FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0	·				
	Р	·				
	Q					

NON-PATENT DOCUMENTS

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U w Х

\(^1 \) A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

R s т

Applicant(s)/Patent Under

2885